

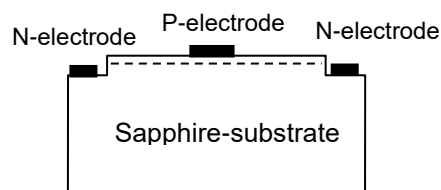
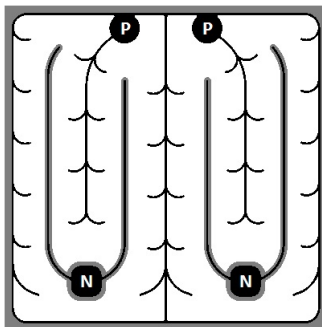
### > Mechanical Specification:

#### (1) Dimension

- Chip size: 45 mil x 45 mil ( $1143 \pm 50 \mu\text{m} \times 1143 \pm 50 \mu\text{m}$ )
- Thickness: 5.9 mil ( $150 \pm 10 \mu\text{m}$ )
- P bonding pad: 3.9 mil ( $100 \pm 10 \mu\text{m}$ )
- N bonding pad: 3.9 mil ( $100 \pm 10 \mu\text{m}$ )

#### (2) Metallization

- Topside P electrode: Au alloy
- Topside N electrode: Au alloy



#### Features:

- High radiant flux
- Long operation life
- Lambertian radiation
- High anti-ESD level

#### Applications:

- UV air purifier
- Printing
- Curing

### > Electro-optical Characteristics at 25°C<sup>(1)</sup>:

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Forward Voltage	V <sub>f1</sub>	I <sub>f</sub> = 10uA	1.6	-	-	V
	V <sub>f</sub>	I <sub>f</sub> = 350mA	-	3.3	3.4	V
Peak Wavelength <sup>(2)</sup>	λ <sub>p</sub>	I <sub>f</sub> = 350mA	385	-	415	nm
Spectra Half-width	Δλ	I <sub>f</sub> = 350mA	-	15	-	nm
Radiant Flux <sup>(3)(4)</sup>	P <sub>o</sub>	I <sub>f</sub> = 350mA λ <sub>p</sub> = 385~400nm (20mW/bin)	440	-	580	mW
		I <sub>f</sub> = 350mA λ <sub>p</sub> = 400~415nm (20mW/bin)	520	-	620	

Note:

- (1) ESD protection during chip handling is recommended.
- (2) Basically, the wavelength span is 30nm; however, customers' special requirements are also welcome.
- (3) Radiant flux is determined by using an Ag-plated TO-can header without an encapsulant.
- (4) Radiant flux measurement allows a tolerance of ±15%.

### > Absolute Maximum Ratings:

Parameter	Symbol	Condition	Rating	Unit
Forward DC Current	If	Ta = 25°C	≤ 700	mA
Junction Temperature	Tj	-	≤ 125	°C
Storage Temperature	Tstg	Chip	-40 ~ +85	°C
		Chip-on-tape/storage	5 ~ 35	°C
		Chip-on-tape/transportation	-20 ~ +65	°C
Temperature during Packaging	-	-	280(<10sec)	°C

Note: Maximum ratings are package dependent. The above maximum ratings were determined using a Metal Core Printed Circuit Board (MCPCB) without an encapsulant. Stresses in excess of the absolute maximum ratings such as forward current and junction temperature may cause damage to the LED.

### > Characteristic Curves: (Peak Wavelength@395nm)

Fig.1 – Relative luminous Intensity vs. Forward Current

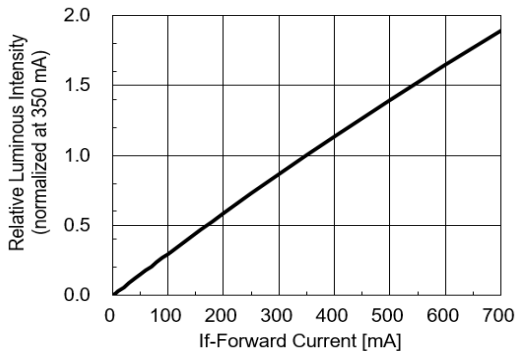


Fig.2 – Forward Current vs. Forward Voltage

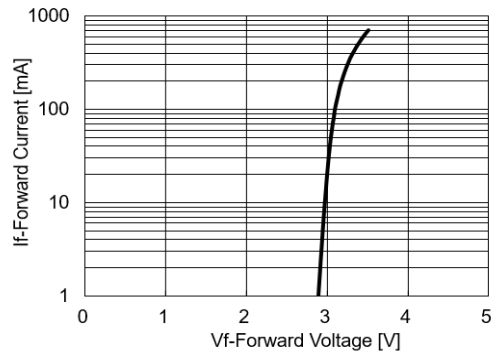


Fig.3 – Relative Intensity (@350mA) vs. Ambient Temperature

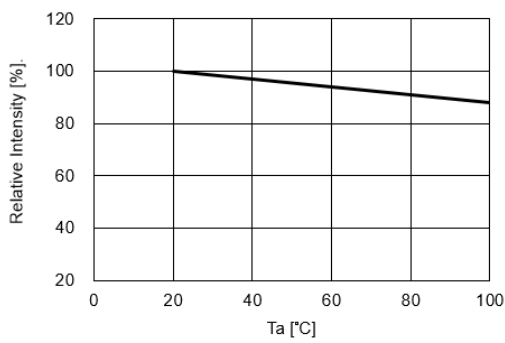


Fig.4 – Forward Voltage (@350mA) vs. Ambient Temperature

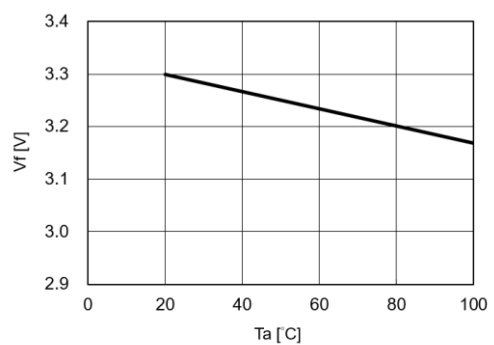


Fig.5 –Peak Wavelength (@350mA) vs. Ambient Temperature

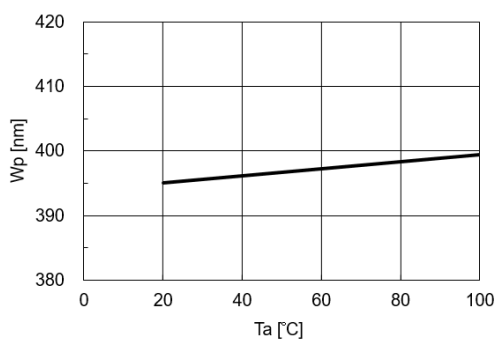
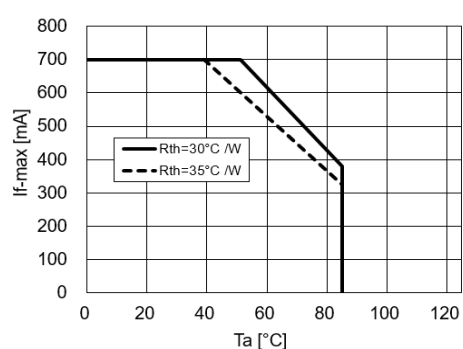


Fig.6 – Maximum Driving Forward DC Current vs. Ambient Temperature (De-rating based on Tj max. = 125°C)



## > Characteristic Curves: (Peak Wavelength@405nm)

Fig.1 – Relative luminous Intensity vs. Forward Current

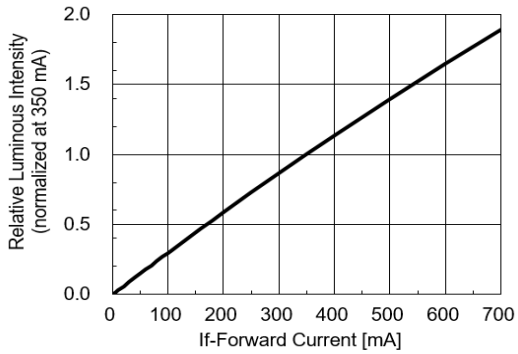


Fig.2 – Forward Current vs. Forward Voltage

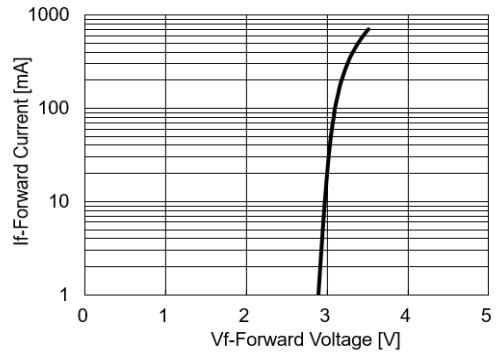


Fig.3 – Relative Intensity (@350mA) vs. Ambient Temperature

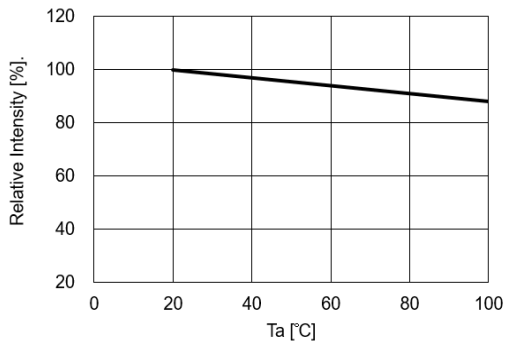


Fig.4 – Forward Voltage (@350mA) vs. Ambient Temperature

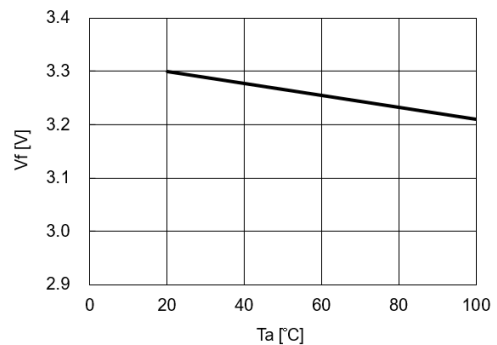


Fig.5 –Peak Wavelength (@350mA) vs. Ambient Temperature

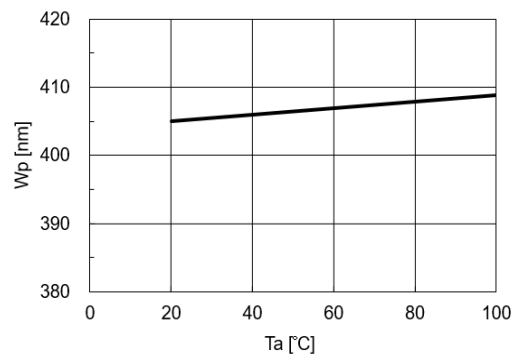


Fig.6 – Maximum Driving Forward DC Current vs. Ambient Temperature (De-rating based on Tj max. = 125°C)

